



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Rinze BENEDICTUS et al.

Examiner: J. Combs-Morillo

Serial No.: 10/642,507

Art Unit: 1742

Filed: August 18, 2003

For: HIGH DAMAGE TOLERANT Al-Cu ALLOY

INFORMATION DISCLOSURE STATEMENT

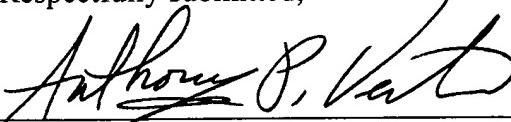
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to Rules 56 and 98, Applicants hereby call the attention of the Patent Office to the references listed on the attached Form PTO 1449.

Applicants present these references so that the Patent Office may, in the first instance, determine any relevancy thereof to the presently claimed invention, see Beckman Instruments, Inc. v. Chemtronics, Inc., 439 F.2d 1369, 1380, 165 USPQ 355, 364 (5th Cir. 1970). Also see Patent Office Rule 104. Applicants respectfully request that these references be expressly considered during the prosecution of this application and made of record herein and appear among the "References Cited" on any patent to issue herefrom. A check for the Rule 1.16(p) fee is enclosed.

Respectfully submitted,

A handwritten signature in black ink, appearing to read "Anthony P. Venturino".

Date: May 25, 2005

By:

APV/pgw
ATTORNEY DOCKET NO. APV31646

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FORM PTO-1449 U.S. Department of Commerce
(Rev. 4/92) Patent and Trademark Office

ATTY. DOCKET NO.
APV31646

SERIAL NO.
10/642,507

INFORMATION DISCLOSURE
STATEMENT BY APPLICANT

(Use several sheets if necessary)

APPLICANT
Rinze BENEDICTUS et al.

FILING DATE
August 18, 2003

GROUP
1742

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	4	2	9	4	6	2	5	10/81	Hyatt et al.			
	4	3	3	6	0	7	5	06/82	Quist et al.			
	5	3	7	6	1	9	2	12/94	Cassada, III			
	5	7	5	9	3	0	2	06/98	Nakai et al.			
	5	8	6	5	9	1	4	02/99	Karabin et al.			
	5	8	7	9	4	7	5	03/99	Karabin			
	6	5	6	9	5	4	2	05/03	Warner et al.			
	6	6	0	2	3	6	1	08/03	Warner et al.			
	6	2	7	7	2	1	9	08/01	Heinz et al.			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
													YES NO	
		1	0	2	6	2	7	0	02/02	EP				Abstract Only
		1	1	1	4	8	7	7	07/01	EP				Abstract Only
		0	9	8	9	1	9	5	03/00	EP				Abstract Only
		2004	0	1	8	7	2	3	03/04	WO				
		2000		3	7	7	0	2	06/00	WO				
		60	0	6	7	6	3	6	04/85	JP				X

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	US Patent Appln. Publication No. 2003/0104990 A1, to Hauer et al. (USSN 10/094,781), filed March 11, 2002, published June 5, 2003.
	US Patent Appln. Publication No. 2002/0031681 A1, to Heinz et al. (USSN 09/876,233, filed June 8, 2001, published March 14, 2002.

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
													YES NO	
		60	2	5	1	2	6	0	12-85	JP				X
			7	2	3	0	3	3	7-96	EP				X
			4	8	9	4	0	8	6-92	EP				X
		1	0	4	5	0	4	3	10/02	EP				Abstract only

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	US Patent Appln. Publication No. 2004/0060618 A1, to Benedictus et al. (USSN 10/639,776), filed August 13, 2003, published April 1, 2004.
	US Patent Appln. Publication No. 2003/0070734 A1, to Heinz et al. (USSN 10/195,483, filed July 16, 2002, published April 17, 2003.
	Davis, J.R., "ASM Specialty Handbook - Aluminium and Aluminium Alloys", ASM International, p 63-64 (1993).
	Davis, J.R., "ASM Specialty Handbook - Aluminium and Aluminium Alloys", ASM International, Paper No. XP-002266795, p. 20 (1996).
	N. Ridlev and J. Pilling, "Superplastic deformation characteristics of some commercial aluminium alloys", Aluminium Technology, London, Book 3, Session B, Pgs. 44.1-44.7 (March, 1986)
	Davis, J.R., ASM Specialty Handbook, "Aluminium-Lithium Alloys", pg. 121 (May, 1994)
	Davis, J.R., ASM Specialty Handbook, "Aluminium and Aluminium Alloys", pgs. 143-147 (1993)
	"ASM Handbook: Vol. 2 Properties and Selection: Nonferrous Alloys and Special-Purpose Materials", ASM International, pgs. 70-79 (1990)
	"ASM Handbook: Vol. 9 Metallography and Microstructures", ASM International, pgs. 364-365 (1985)

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MAY 25 2005

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	Office action, Jan. 25, 2005 for US Pat. App. Ser. No. 10/642,518
	Office action, Jan. 12, 2005 for US Pat. App. Ser. No. 10/639,776
	Office action, Nov. 1, 2004 for US Pat. App. Ser. No. 09/876,233
	Office action, Oct. 6, 2004 for US Pat. App. Ser. No. 10/195,483
	ASTM E112-96, Standard Test Methods for Determining Average Grain Size (1996)

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DATE CONSIDERED

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